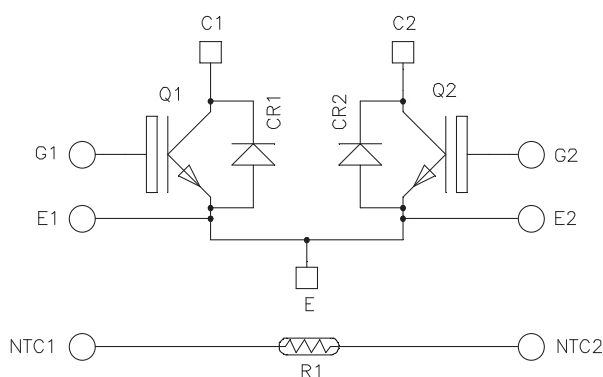


## Product Overview

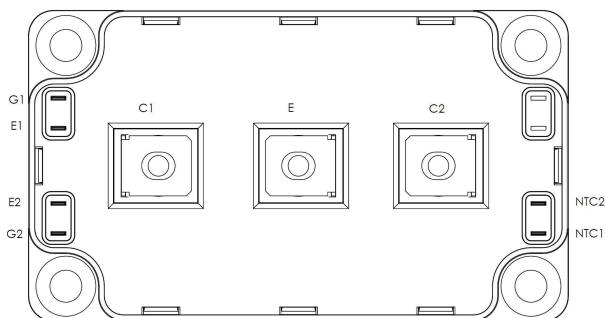
The APTGX300DU170T6G device is a dual common emitter 1700V, 300A Insulated-Gate Bipolar Transistor (IGBT) 7 power module.

The following figures show the electrical diagram and pinout location of the device.

**Figure 1.** Electrical Diagram



**Figure 2.** Pinout Location



### Note:

- All ratings are at  $T_j = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified.



These devices are sensitive to electrostatic discharge. Proper handling procedures must be followed.

## Features

The APTGX300DU170T6G device has the following key features:

- IGBT 7
  - Low-voltage drop
  - Low-leakage current
- Very low-stray inductance
- Kelvin emitter for easy drive
- M5 power connectors
- Internal thermistor for temperature monitoring
- Al<sub>2</sub>O<sub>3</sub> substrate and copper base plate

## Benefits

The APTGX300DU170T6G device has the following benefits:

- High efficiency converter
- Direct mounting to heatsink (isolated package)
- Low junction-to-case thermal resistance
- Low profile
- RoHS compliant

## Potential Application

The APTGX300DU170T6G device has the following potential application:

- AC switches

## 1. Electrical Specifications

The following sections show the electrical specifications of the APTGX300DU170T6G device.

### 1.1 IGBT Characteristics (Per IGBT)

The following table lists the absolute maximum ratings (per IGBT) of the APTGX300DU170T6G device.

**Table 1-1.** Absolute Maximum Ratings

Symbol	Parameter	Maximum Ratings	Unit
$V_{CES}$	Collector-emitter voltage	1700	V
$I_C$	Continuous collector current	$T_C = 25\text{ }^{\circ}\text{C}$	A
		$T_C = 70\text{ }^{\circ}\text{C}$	
$I_{CM}$	Pulsed collector current, $t_p$ limited by $T_{J(max)}$	600	
$V_{GE}$	Gate-emitter voltage	$\pm 20$	V
$P_D$	Power dissipation	$T_C = 25\text{ }^{\circ}\text{C}$	W

The following table lists the electrical characteristics (per IGBT) of the APTGX300DU170T6G device.

**Table 1-2.** Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
$I_{CES}$	Zero gate voltage collector current	$V_{GE} = 0V$ ; $V_{CE} = 1700V$	—	—	25	$\mu A$
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15V$ $I_C = 300A$ $T_J = 25\text{ }^{\circ}\text{C}$	—	1.7	2	V
		$T_J = 125\text{ }^{\circ}\text{C}$	—	1.95	—	
		$T_J = 175\text{ }^{\circ}\text{C}$	—	2.1	—	
$V_{GE(th)}$	Gate threshold voltage	$V_{GE} = V_{CE}$ ; $I_C = 6.3\text{ mA}$	5.15	5.8	6.45	
$I_{GES}$	Gate-emitter leakage current	$V_{GE} = 20V$ ; $V_{CE} = 0V$	—	—	150	nA

The following table lists the dynamic characteristics (per IGBT) of the APTGX300DU170T6G device.

**Table 1-3.** Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min.	Typ.	Max.	Unit
C <sub>ies</sub>	Input capacitance	V <sub>GE</sub> = 0V V <sub>CE</sub> = 25V f = 100 kHz		—	31.3	—	nF
C <sub>oes</sub>	Output capacitance			—	0.5	—	
C <sub>res</sub>	Reverse transfer capacitance			—	0.11	—	
Q <sub>G</sub>	Gate charge	V <sub>GE</sub> = ±15V V <sub>CE</sub> = 900V I <sub>C</sub> = 300A		—	2.8	—	μC
T <sub>d(on)</sub>	Turn-on delay time	V <sub>GE</sub> = ±15V V <sub>Bus</sub> = 900V I <sub>C</sub> = 300A R <sub>G</sub> = 2.2Ω	T <sub>J</sub> = 25 °C	—	172	—	ns
			T <sub>J</sub> = 125 °C	—	186	—	
			T <sub>J</sub> = 175 °C	—	192	—	
T <sub>r</sub>	Rise time		T <sub>J</sub> = 25 °C	—	41	—	
			T <sub>J</sub> = 125 °C	—	67	—	
			T <sub>J</sub> = 175 °C	—	73	—	
T <sub>d(off)</sub>	Turn-off delay time		T <sub>J</sub> = 25 °C	—	441	—	
			T <sub>J</sub> = 125 °C	—	538	—	
			T <sub>J</sub> = 175 °C	—	583	—	
T <sub>f</sub>	Fall time		T <sub>J</sub> = 25 °C	—	270	—	
			T <sub>J</sub> = 125 °C	—	429	—	
			T <sub>J</sub> = 175 °C	—	556	—	
E <sub>on</sub>	Turn-on energy	V <sub>GE</sub> = ±15V V <sub>Bus</sub> = 900V I <sub>C</sub> = 300A R <sub>G</sub> = 2.2Ω di/dt = 6400 A/μs dv/dt = 6000 V/μs	T <sub>J</sub> = 25 °C	—	35.4	—	mJ
			T <sub>J</sub> = 125 °C	—	55	—	
			T <sub>J</sub> = 175 °C	—	68.2	—	
E <sub>off</sub>	Turn-off energy		T <sub>J</sub> = 25 °C	—	47.2	—	
			T <sub>J</sub> = 125 °C	—	66.8	—	
			T <sub>J</sub> = 175 °C	—	80.4	—	
R <sub>Gint</sub>	Internal gate resistance			—	0.65	—	Ω
I <sub>sc</sub>	Short circuit data	V <sub>GE</sub> ≤ 15V V <sub>Bus</sub> = 1000V t <sub>p</sub> ≤ 8 μs	T <sub>J</sub> = 150 °C	—	1100	—	A
		V <sub>GE</sub> ≤ 15V V <sub>Bus</sub> = 1000V t <sub>p</sub> ≤ 7 μs	T <sub>J</sub> = 175 °C	—	1000	—	
R <sub>thJC</sub>	Junction-to-case thermal resistance			—	—	0.145	°C/W

## 1.2 Diode Characteristics (Per Diode)

The following table lists the diode characteristics (per diode) of the APTGX300DU170T6G device.

**Table 1-4.** Diode Characteristics

Symbol	Characteristic	Test Conditions		Min.	Typ.	Max.	Unit
V <sub>RRM</sub>	Peak repetitive reverse voltage			—	—	1700	V
I <sub>RM</sub>	Reverse leakage current	V <sub>R</sub> = 1700V		—	—	25	μA
I <sub>FRM</sub>	Repetitive forward current, t <sub>p</sub> limited by T <sub>J(max)</sub>			—	600	—	A
I <sup>2</sup> t	I <sup>2</sup> t value	t <sub>p</sub> = 10 ms V <sub>R</sub> = 0V	T <sub>J</sub> = 125 °C	—	6000	—	A <sup>2</sup> s
			T <sub>J</sub> = 175 °C	—	4900	—	
I <sub>F</sub>	DC forward current			—	300	—	A
V <sub>F</sub>	Diode forward voltage	I <sub>F</sub> = 300A V <sub>GE</sub> = 0V	T <sub>J</sub> = 25 °C	—	2.35	2.7	V
			T <sub>J</sub> = 125 °C	—	2.25	—	
			T <sub>J</sub> = 175 °C	—	2.1	—	
I <sub>RRM</sub>	Reverse recovery current	V <sub>GE</sub> = -15V I <sub>F</sub> = 300A V <sub>R</sub> = 900V di/dt = 6400 A/μs	T <sub>J</sub> = 25 °C	—	320	—	A
			T <sub>J</sub> = 125 °C	—	370	—	
			T <sub>J</sub> = 175 °C	—	390	—	
Q <sub>rr</sub>	Reverse recovery charge		T <sub>J</sub> = 25 °C	—	31	—	μC
			T <sub>J</sub> = 125 °C	—	70	—	
			T <sub>J</sub> = 175 °C	—	87	—	
E <sub>rr</sub>	Reverse recovery energy		T <sub>J</sub> = 25 °C	—	19	—	mJ
			T <sub>J</sub> = 125 °C	—	39.7	—	
			T <sub>J</sub> = 175 °C	—	58.3	—	
R <sub>thJC</sub>	Junction-to-case thermal resistance			—	—	0.265	°C/W

### 1.3 Thermal and Package Characteristics

The following table lists the thermal and package characteristics of the APTGX300DU170T6G device.

**Table 1-5.** Thermal and Package Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Unit
V <sub>ISOL</sub>	RMS isolation voltage, any terminal-to-case t = 1 min, 50/60 Hz	4000	—	—	V
L <sub>stray</sub>	Stray inductance module	—	15	—	nH
d <sub>creep</sub>	Creepage distance terminal-to-terminal	—	14.5	—	mm
	Creepage distance terminal-to-heatsink	—	15.9	—	
d <sub>clear</sub>	Clearance distance terminal-to-terminal	—	11.4	—	
	Clearance distance terminal-to-heatsink	—	12.1	—	
R <sub>CE</sub>	Lead resistance terminal-to-chip	T <sub>C</sub> = 25 °C, per switch		0.5	mΩ
T <sub>J</sub>	Operating junction temperature range	–40	—	175	°C
T <sub>STG</sub>	Storage temperature range	–40	—	125	
T <sub>C</sub>	Operating case temperature	–40	—	125	
τ <sub>M</sub>	Mounting torque	To heatsink	M6	3	N.m
		For terminals	M5	2	
Wt	Package weight	—	282	—	g

The following table lists the temperature sensor NTC of the APTGX300DU170T6G device.

**Table 1-6.** Temperature Sensor NTC

Symbol	Characteristic	Min.	Typ.	Max.	Unit
R <sub>25</sub>	Resistance at 25 °C	—	50	—	kΩ
ΔR <sub>25</sub> /R <sub>25</sub>	—	—	5	—	%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15K	—	3952	—	K
ΔB/B	—	T <sub>C</sub> = 100 °C		4	%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

**Note:** For more information, see [APT0406—Using NTC Temperature Sensor Integrated into Power Module](#).

## 1.4 Typical IGBT Performance Curve

The following figures show the IGBT performance curves of the APTGX300DU170T6G device.

Figure 1-1. Maximum Thermal Impedance

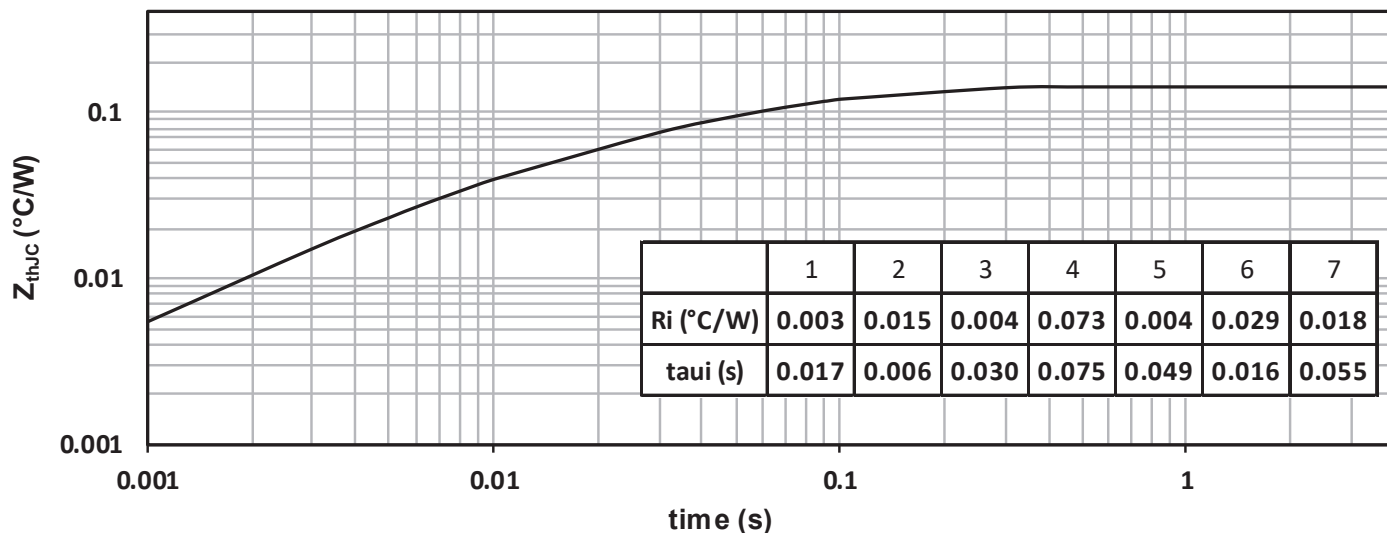


Figure 1-2. Output Characteristics,  $V_{GE} = 15V$

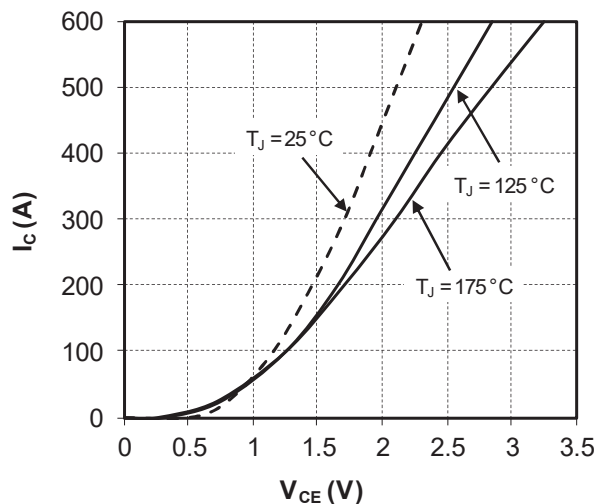


Figure 1-3. Output Characteristics,  $T_J = 175^\circ C$

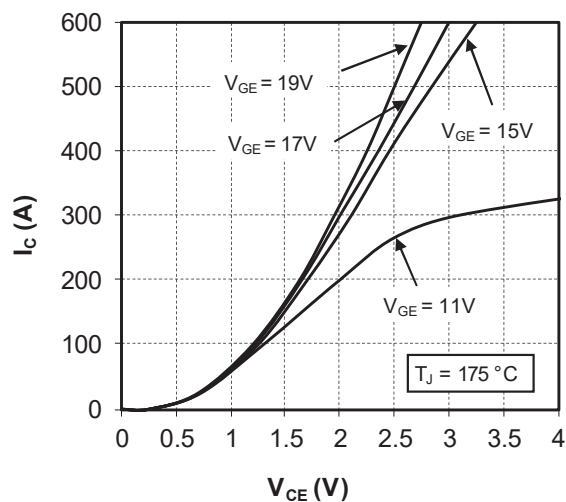


Figure 1-4. Switching Losses vs. Gate Resistance

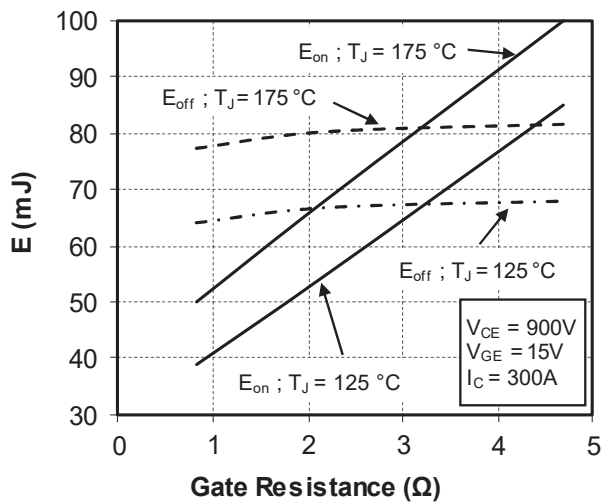


Figure 1-5. Switching Losses vs. Collector Current

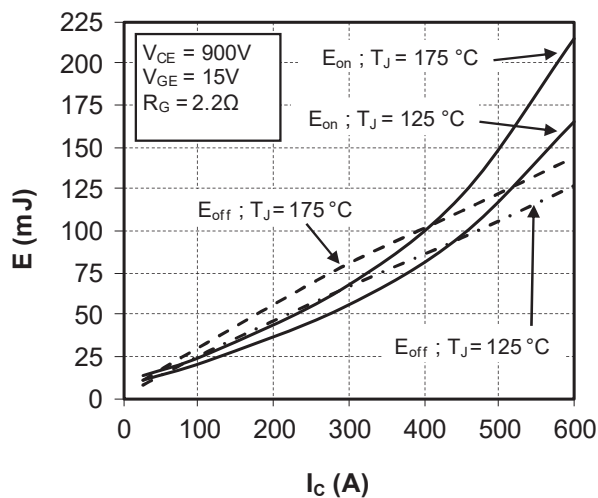


Figure 1-6. Operating Frequency vs. Collector Current

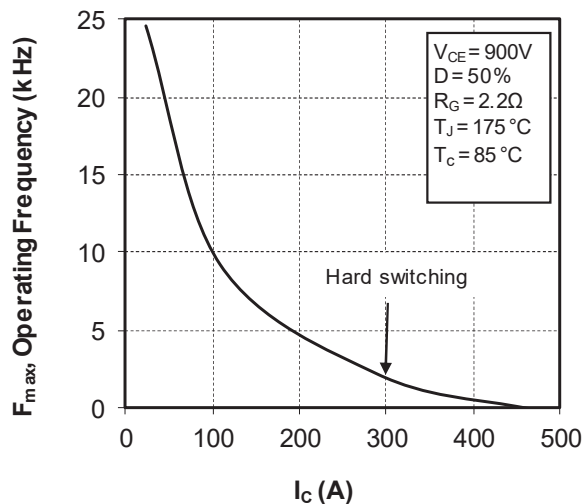


Figure 1-7. Gate Charge Characteristics

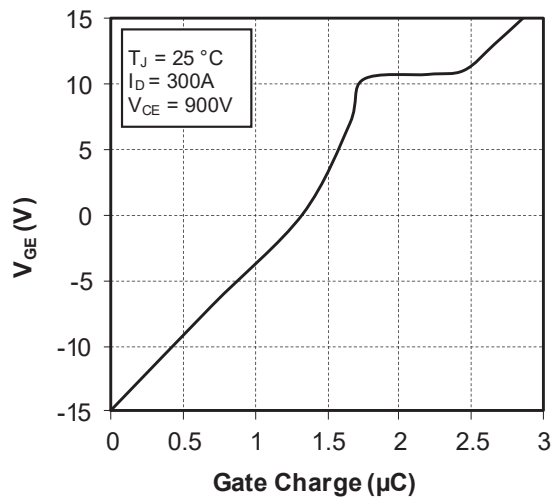


Figure 1-8. Transfer Characteristics

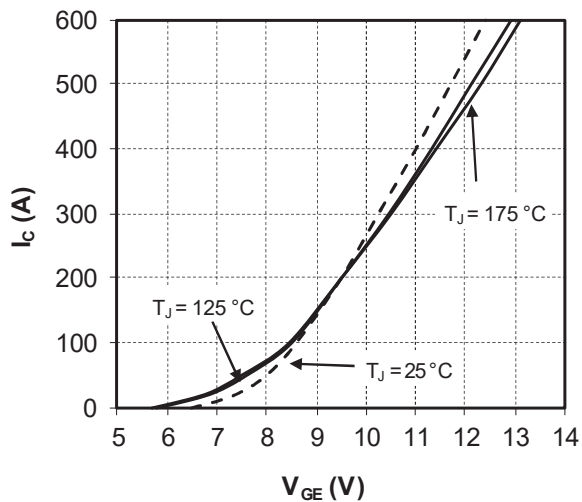


Figure 1-9. Capacity Characteristics

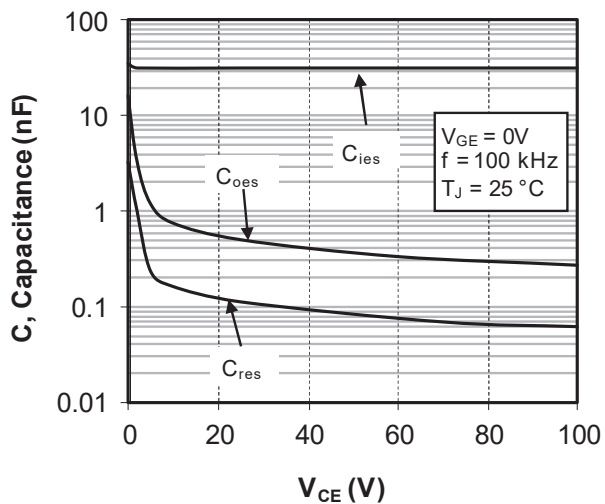
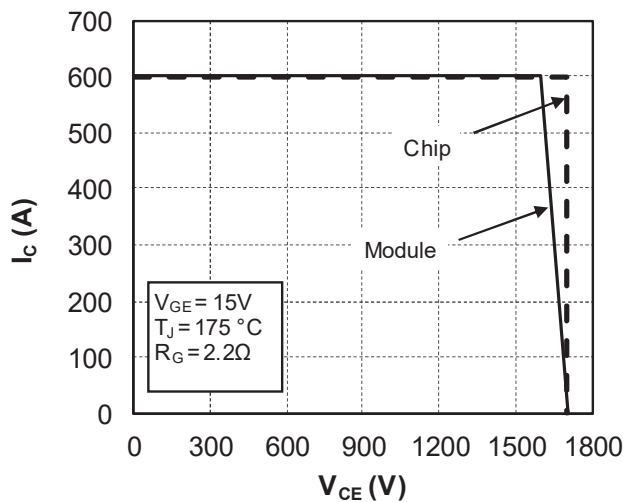


Figure 1-10. Reverse Bias Safe Operating Area



## 1.5 Typical Diode Performance Curve

The following figures show the diode performance curves of the APTGX300DU170T6G device.

Figure 1-11. Maximum Thermal Impedance

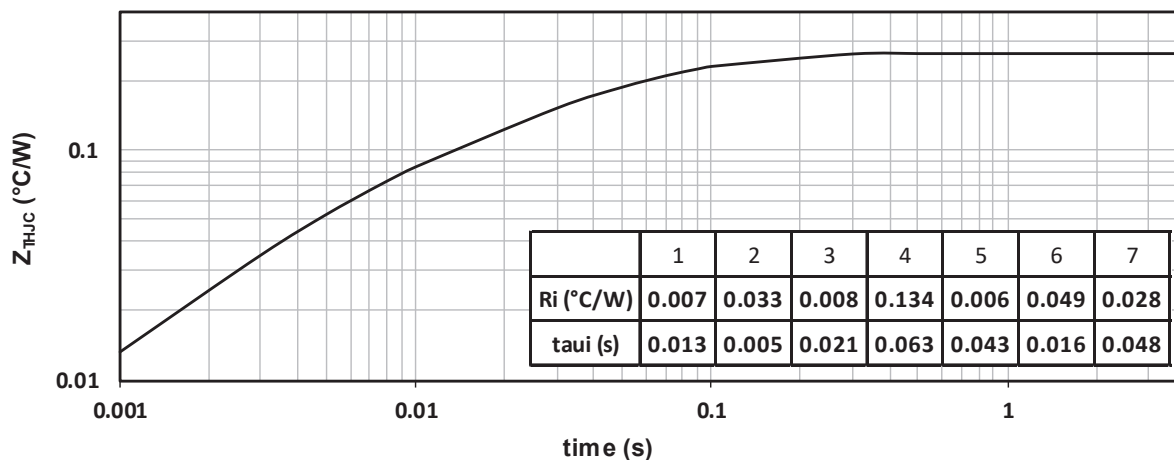


Figure 1-12. Forward Characteristics

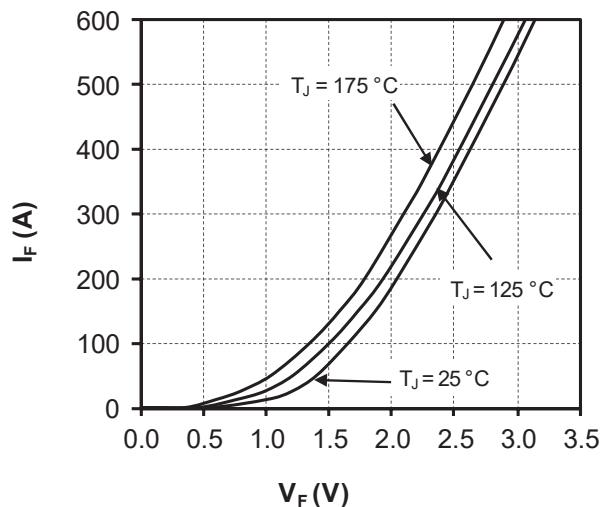


Figure 1-13. Switching Losses vs. Gate Resistance

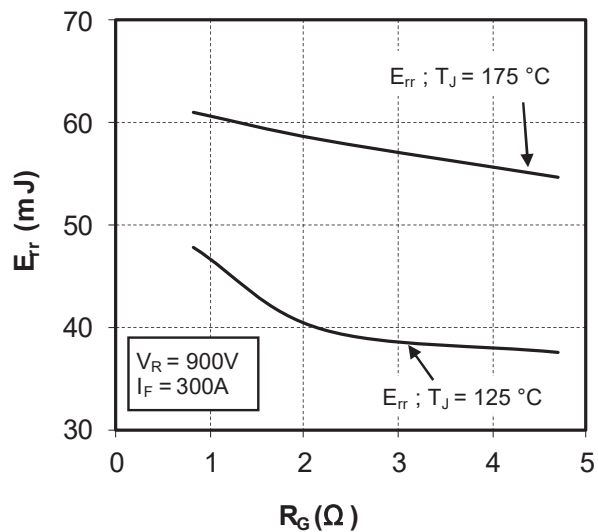
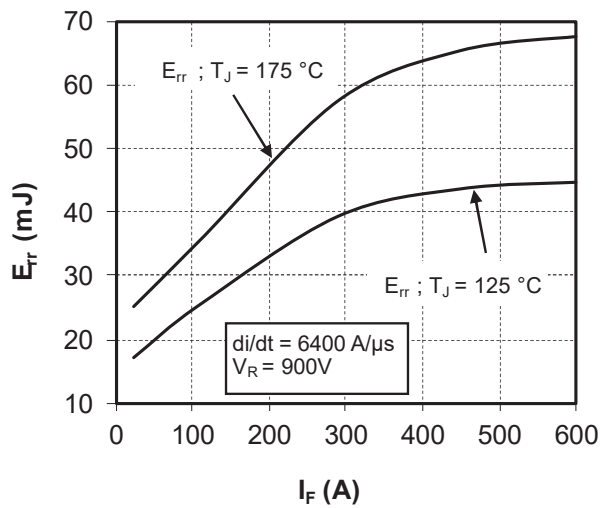


Figure 1-14. Switching Losses vs. Forward Current



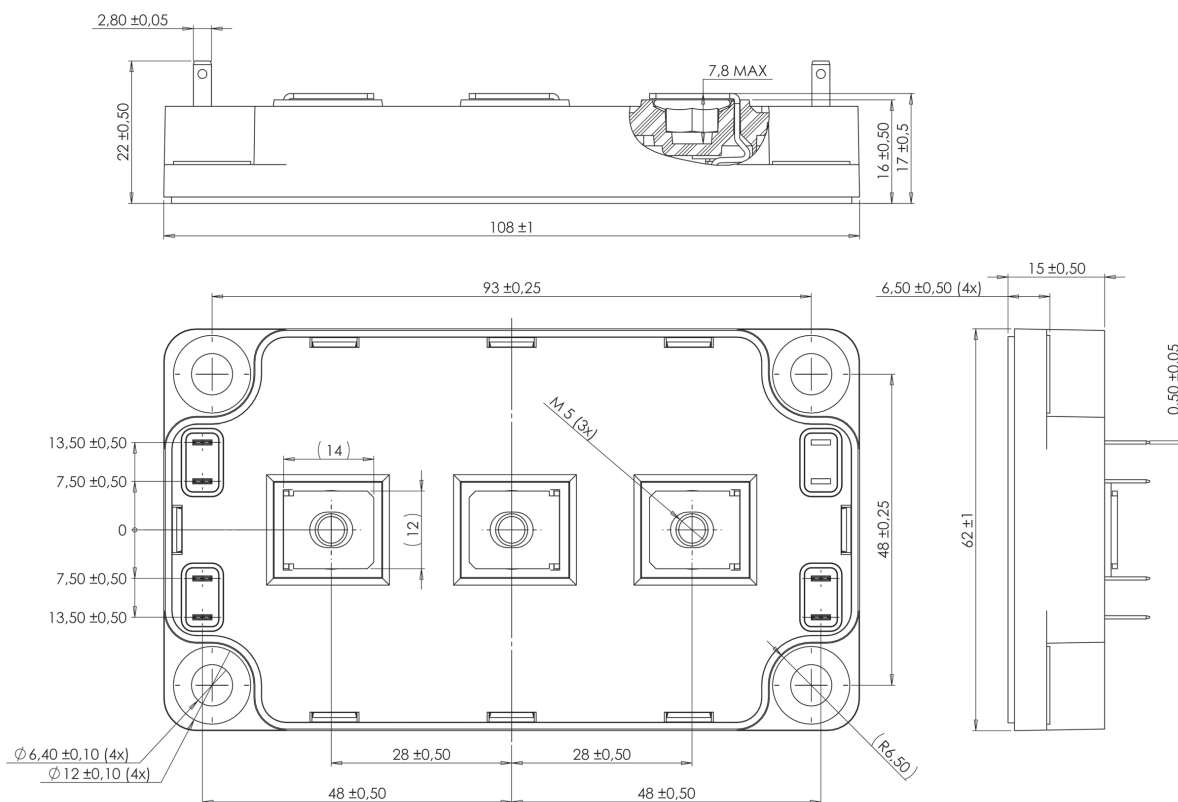
## 2. Package Specifications

The following section shows the package specification of the APTGX300DU170T6G device.

### 2.1 Package Outline

The following figure shows the package outline drawing of the APTGX300DU170T6G device. The dimensions in the following figure are in millimeters.

**Figure 2-1.** Package Outline Drawing



**Note:** For more information, see [APT0601 - Mounting Instructions for SP6 Power Modules](#).

### 3. Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

Revision	Date	Description
A	11/2024	Initial revision

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ISBN: 979-8-3371-0060-9

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